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TABLE OF CONTENTS

3-Dimensional Structural Control Of Silica Microparticles Using Photoresponsive Materials	1
<i>T. Ikawa, T. Furukawa, H. Shibata, M. Narita, M. Mouri, O. Watanabe, M. Tawata</i>	
Concentrated Colloidal Dispersion Of Decanoic Acid Self-Assembled Monolayer Protected CeO₂ Nanoparticles Up To 77 Wt% In Nonpolar Organic Solvents	7
<i>T. Arita, J. Yoo, Y. Ueda, T. Adschiri</i>	
Author Index	